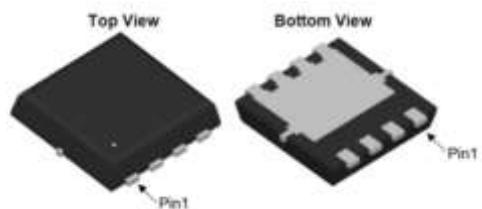


30V_{DS}/±20V_{GS} N-Channel Enhancement Mode MOSFET

Features

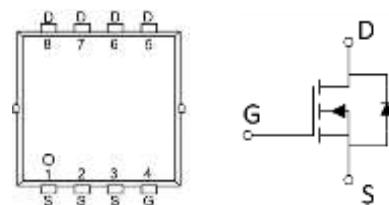
- V_{DS}=30V,I_D=35A
- R_{DS(ON)}=12mΩ (TYP.) V_{GS}=10V
- R_{DS(ON)}=18mΩ (TYP.) V_{GS}=4.5V
- Reliable and Rugged
- Avalanche Rated
- Low On-Resistance
- High Current Capability

PDFN3333



Applications

- Load Switch
- Power management in portable/desktop PCs
- DC/DC conversion



Ordering Information

Device	package	Device Marking	Package Qty.
AGM310AP1	PDFN3333	**	5000/PCS

Absolute Maximum Ratings (T_C=25°C,unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (V _{GS} =0V)	V _{DS}	30	V
Gate-Source Voltage (V _{GS} =0V,static)	V _{GS}	±20	V
Continuous Drain Current (T _C =25°C)	I _D	35	A
Continuous Drain Current (T _C =100°C)		18	A
Pulsed Drain Current	I _{DM}	180	A
Single Pulsed Avalanche Energy	E _{AS}	22	mJ
Maximum Power Dissipation (T _C =25°C)	P _D	20	W
Operating,Storage Temperature Range	T _J ,T _{STG}	-55~150	°C

Electrical Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V,I _D =250μA	30	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V	-	-	1	μA
Gate -Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} ,I _D =250μA	1	1.8	3	V
Drain-Source On-stage Resistance	R _{DS(ON)}	V _{GS} =10V,I _D =20A	-	-	12	mΩ
		V _{GS} =4.5V,I _D =20A	-	-	20	

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance,Junction-to-Case	R _{θJC}	-	6	-	°C/W
Thermal Resistance,Junction-to-Ambient	R _{θJA}	-	75	-	°C/W

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	V _{DS} =15V V _{GS} =0V f=1MHz	-	572	-	pF
Output capacitance	C _{oss}		-	81	-	
Reverse transfer capacitance	C _{rss}		-	65	-	
Gate Resistance	R _g	f=1MHz	-	1.5	-	Ω
Total Gate Charge	Q _g	V _{DS} =15V V _{GS} =10V I _D =20A	-	15.9	-	nC
Gate Source Charge	Q _{gs}		-	2.9	-	
Gate Drain Charge	Q _{gd}		-	3.3	-	
Turn-on delay Time	t _{d(on)}	V _{GS} =10V V _{DS} =15V R _L =0.75Ω R _G =3Ω	-	6.3	-	ns
Rise time	t _r		-	2.7	-	
Turn-off delay Time	t _{d(off)}		-	18.6	-	
Fall time	t _f		-	4.2	-	

Reverse Diode Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Body Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _{SD} =1A	-		1.2	V
Reverse Recovery Time	t _{rr}	V _{GS} =0V, I _{SD} =20A d _i /d _t =500A/μs	-	32	50	ns
Reverse Recovery Charge	Q _{rr}		-	13.5	20	nC

Electrical Characteristics Diagrams

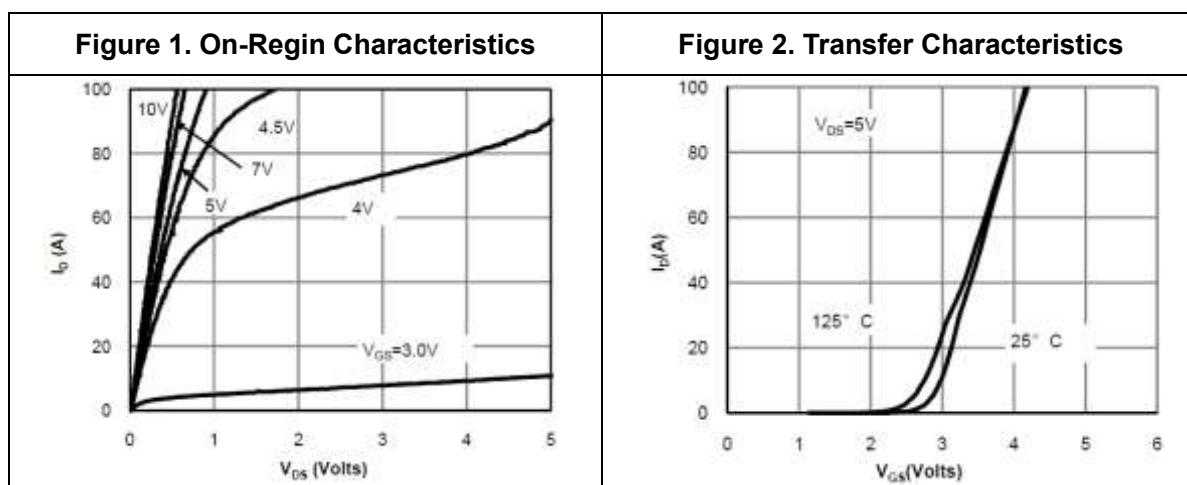


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

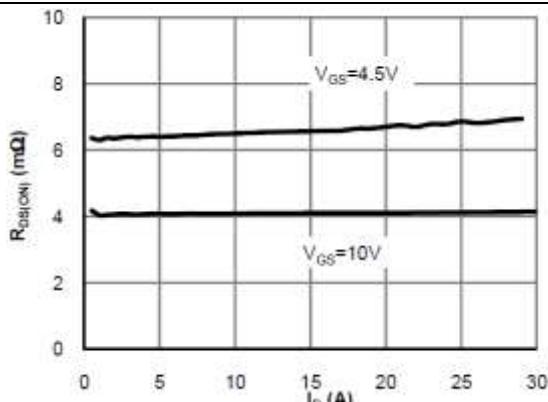


Figure 4. On-Resistance vs. Junction Temperature

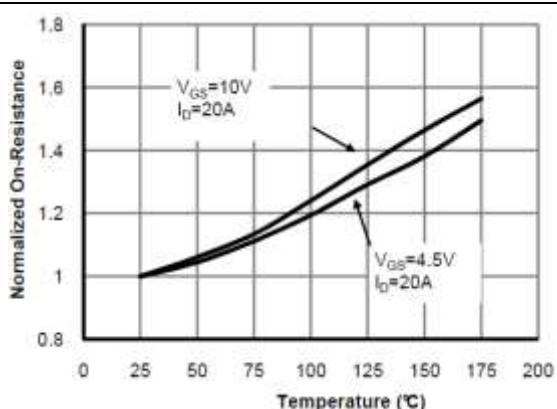


Figure 5. On-Resistance vs. Gate-Source Voltage

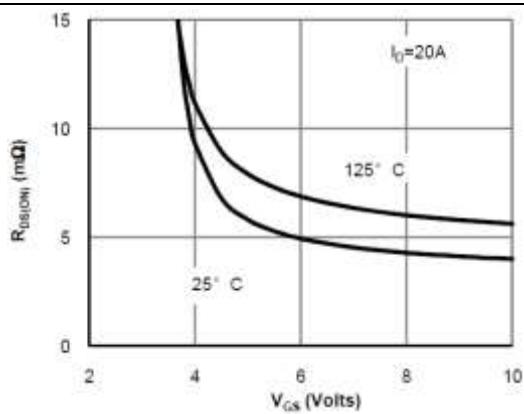


Figure 6. Body-Diode Characteristics

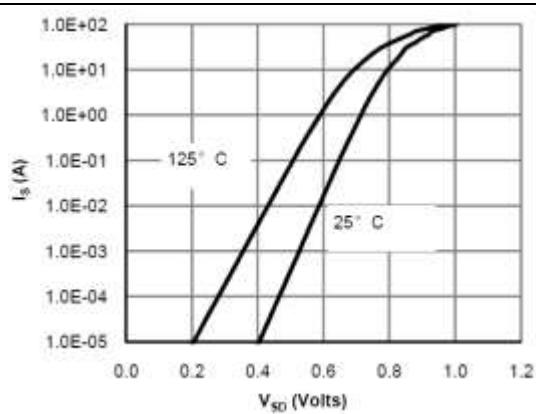


Figure 7. Gate-Charge Characteristics

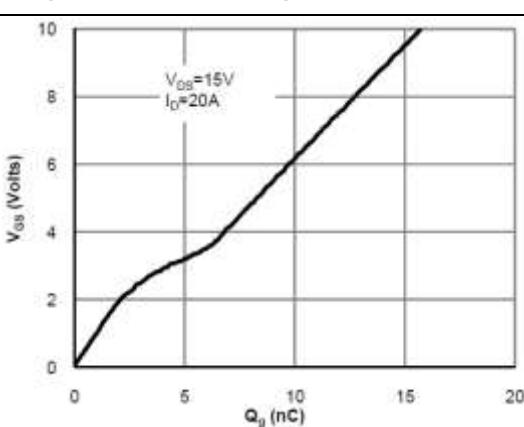
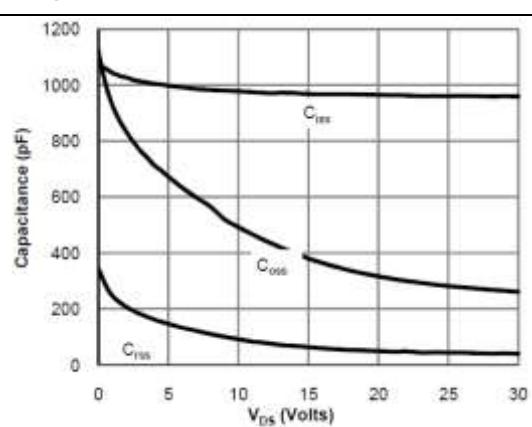


Figure 8. Capacitance Characteristics



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